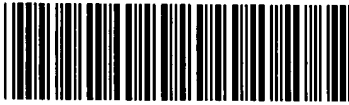


Search Notes

Application/Control No.

10/655,533

Examiner

Tam M. Nguyen

Applicant(s)/Patent under
Reexamination

JAKKULA ET AL.

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
585	240 241	1/4/2007	TN
208	179	1/4/2007	tn

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INTERFERENCE SEARCHED - SEE PGPUB PRINTOUT	1/8/2007	TN